

**Search Notes**

Application/Control No.

10/550,349

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under  
Reexamination

VAN DER HEIJDEN, MARK

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	292	1/30/2008	PN
	302		
	294		
	149		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
330	292	1/30/2008	PN
	302		
	294		
	149		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	1/30/2008	PN